International Rectifier

IRF5210S/L

HEXFET® Power MOSFET

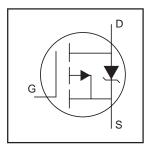
- Advanced Process Technology
- Surface Mount (IRF5210S)
- Low-profile through-hole (IRF5210L)
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated

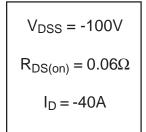
Description

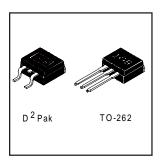
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D^2 Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D^2 Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

The through-hole version (IRF5210L) is available for low-profile applications.







Absolute Maximum Ratings

		,		
	Parameter	Max.	Units	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10VS	-40		
I _D @ T _C = 100°C Continuous Drain Current, V _{GS} @ -10VS		-29	A	
I _{DM}	Pulsed Drain Current ①⑤	-140		
P _D @T _A = 25°C	Power Dissipation	3.8	W	
P _D @T _C = 25°C	Power Dissipation	200	W	
	Linear Derating Factor	1.3	W/°C	
V_{GS}	Gate-to-Source Voltage	± 20	V	
E _{AS}	Single Pulse Avalanche Energy@®	780	mJ	
I _{AR}	Avalanche Current®	-21	А	
E _{AR}	Repetitive Avalanche Energy①	20	mJ	
dv/dt	Peak Diode Recovery dv/dt 3 5	-5.0	V/ns	
TJ	Operating Junction and	-55 to + 175		
T _{STG}	Storage Temperature Range		∞	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)		

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		0.75	0000
$R_{\theta JA}$	Junction-to-Ambient (PCB Mounted, steady-state)**		40	°C/W

Electrical Characteristics $@T_J = 25^{\circ}C$ (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-100			V	$V_{GS} = 0V, I_D = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.11		V/°C	Reference to 25°C, I _D = -1mA [©]
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.06	Ω	V _{GS} = -10V, I _D = -24A ④
V _{GS(th)}	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
9 _{fs}	Forward Transconductance	10			S	$V_{DS} = -50V, I_{D} = -21A$
I _{DSS}	Drain-to-Source Leakage Current			-25	μА	$V_{DS} = -100V, V_{GS} = 0V$
IDSS	Brain to obtaine Leakage Current			-250	μΑ	$V_{DS} = -80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	IIA I	$V_{GS} = -20V$
Qg	Total Gate Charge			180		I _D = -21A
Q _{gs}	Gate-to-Source Charge			25	nC	$V_{DS} = -80V$
Q_{gd}	Gate-to-Drain ("Miller") Charge			97		V _{GS} = -10V, See Fig. 6 and 13 4 5
t _{d(on)}	Turn-On Delay Time		17			$V_{DD} = -50V$
t _r	RiseTime		86			$I_{D} = -21A$
t _{d(off)}	Turn-Off Delay Time		79		ns	$R_G = 2.5\Omega$
t _f	FallTime		81			$R_D = 2.4\Omega$, See Fig. 10 @
L _S	Internal Source Inductance		7.5		nH	Between lead,
					'"'	and center of die contact
C _{iss}	Input Capacitance		2700			$V_{GS} = 0V$
Coss	Output Capacitance		790		pF	$V_{DS} = -25V$
C _{rss}	Reverse Transfer Capacitance		450		1	f = 1.0MHz, See Fig. 5 ^⑤

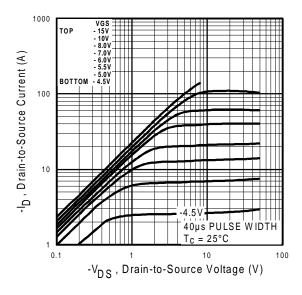
Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions				
Is	Continuous Source Current			40		MOSFET symbol				
	(Body Diode)	-40	-40	Α	showing the					
I _{SM}	Pulsed Source Current		-140			4.40	1.40	4.40	''	integral reverse
	(Body Diode) ①			-140		p-n junction diode.				
V _{SD}	Diode Forward Voltage			-1.6	V	$T_J = 25^{\circ}C$, $I_S = -24A$, $V_{GS} = 0V$ ④				
t _{rr}	Reverse Recovery Time		170	260	ns	$T_J = 25^{\circ}C, I_F = -21A$				
Q _{rr}	Reverse Recovery Charge		1.2	1.8	μC	di/dt = -100A/µs 4 5				
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)								

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- $\begin{tabular}{ll} \hline @ Starting $T_J = 25^{\circ}C$, $L = 3.1mH$ \\ $R_G = 25\Omega$, $I_{AS} = -21A$. (See Figure 12) \\ \hline \end{tabular}$
- © Uses IRF5210 data and test conditions
- ** When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994.



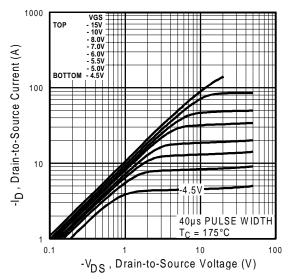
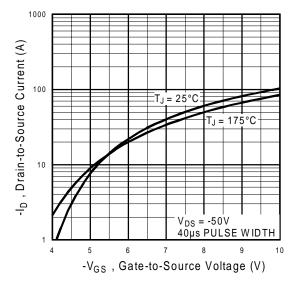


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics





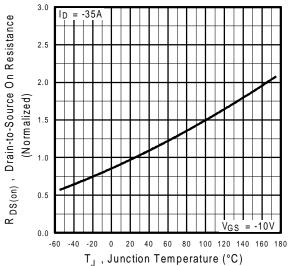


Fig 4. Normalized On-Resistance Vs. Temperature

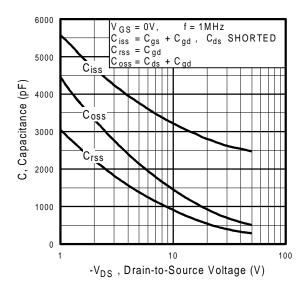


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

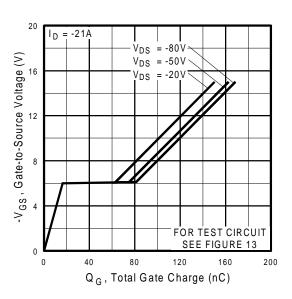


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

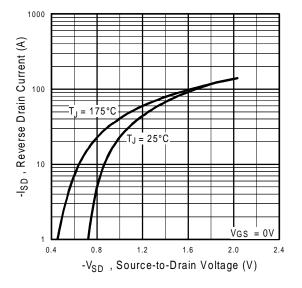


Fig 7. Typical Source-Drain Diode Forward Voltage

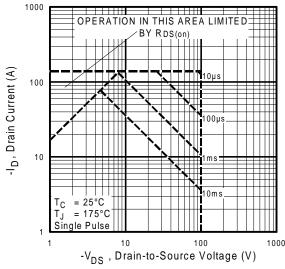


Fig 8. Maximum Safe Operating Area

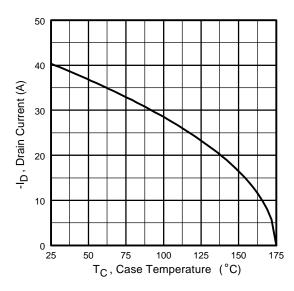


Fig 9. Maximum Drain Current Vs. Case Temperature

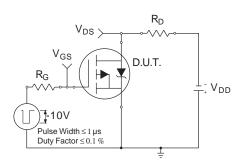


Fig 10a. Switching Time Test Circuit

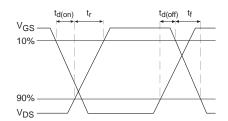


Fig 10b. Switching Time Waveforms

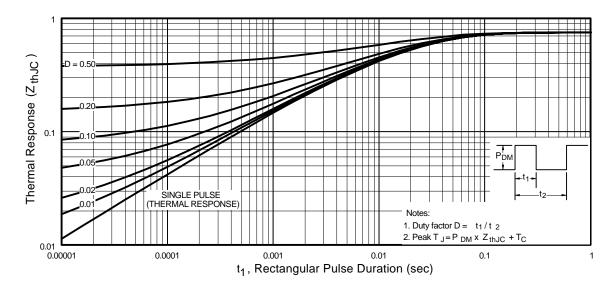


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

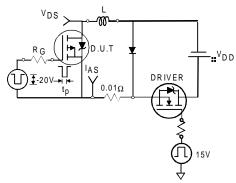


Fig 12a. Unclamped Inductive Test Circuit

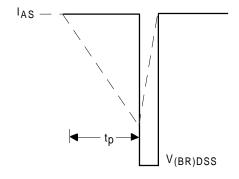


Fig 12b. Unclamped Inductive Waveforms

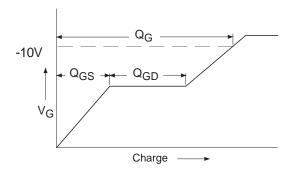


Fig 13a. Basic Gate Charge Waveform

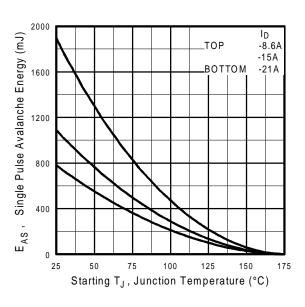


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

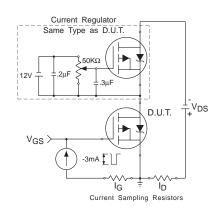
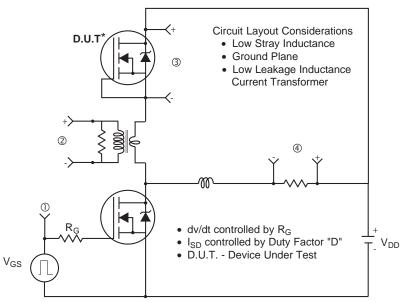
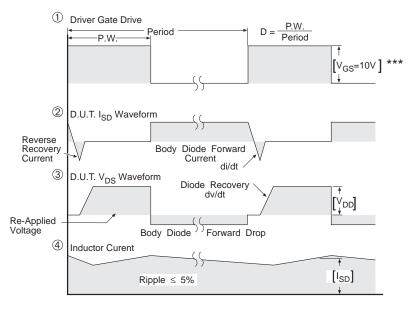


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



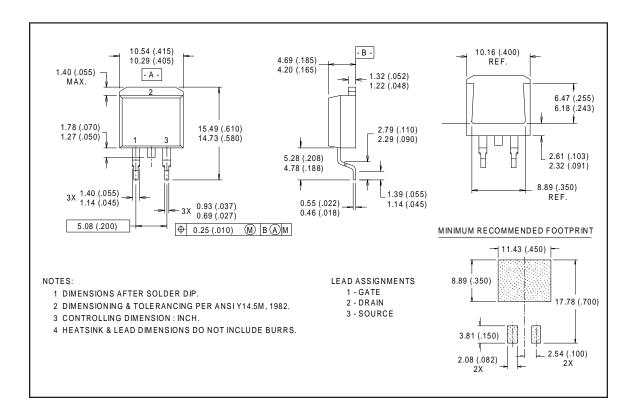
* Reverse Polarity of D.U.T for P-Channel



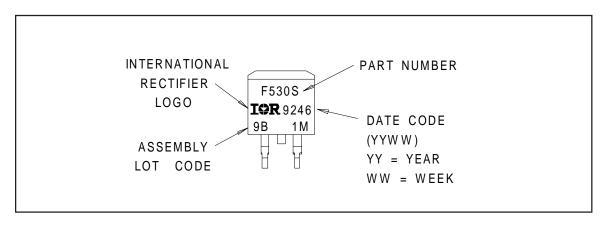
*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

Fig 14. For P-Channel HEXFETS

D²Pak Package Outline

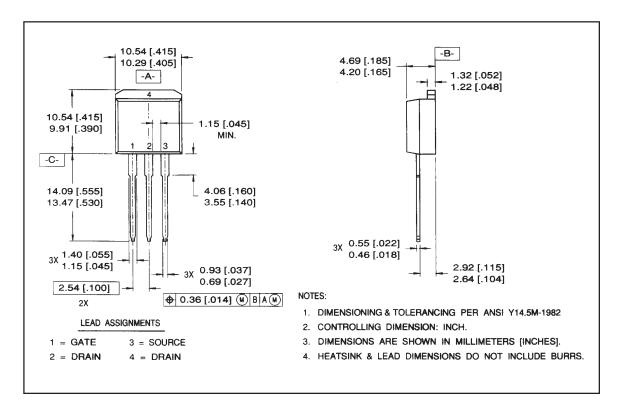


Part Marking Information D²Pak

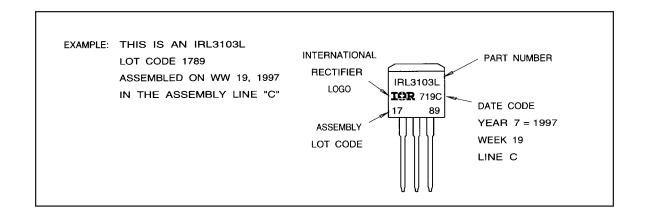


Package Outline

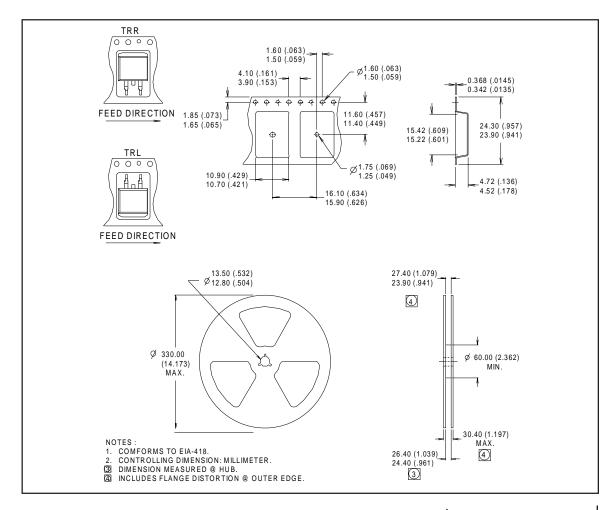
TO-262 Outline



Part Marking Information TO-262



Tape & Reel Information D²Pak



International Rectifier

WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331

EUROPEAN HEADQUARTERS: Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020

IR CANADA: 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 2Z8, Tel: (905) 475 1897

IR GERMANY: Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

IR ITALY: Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

IR FAR EAST: K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086

IR SOUTHEAST ASIA: 315 Outram Road, #10-02 Tan Boon Liat Building, Singapore 0316 Tel: 65 221 8371

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